Search Notes



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09/315,901

Examiner

Applicant(s)/Patent under Reexamination

DULTZ ET AL.

Art Unit

Christopher A. Revak

2131

	SEARCHED					
Class	Subclass	Date	Examiner			
380	37,42,255- 257,259, 260,264	7/22/2005	CR			
380	277-279	7/22/2005	CR			
380	44,54	7/22/2005	CR			
713	168,171	7/22/2005	CR			
713	151,172	7/22/2005	CR			
713	182,185	7/22/2005	CR			
705	65,76,77	7/22/2005	CR			
380	243,244	7/22/2005	CR			
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
713	171,172	7/22/2005	CR			
713	182,185	7/22/2005	CR			
705	65,76,77	7/22/2005	CR			
380/37,42,44,54, 255- 257,259, 260,264,277- 279		7/22/2005	CR			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DÄTE	EXMR		
BRS Text Search USPAT, DERWENT, JPO, EPO, IBM TDB, US PGPUB, USOCR	7/22/2005	CR		
DIALOG Text Search COMPSCI, ELECTRON, SOFTWARE	7/22/2005	CR		
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